

EPC2051 – Enhancement Mode Power Transistor

V_{DS} , 100 V

$R_{DS(on)}$, 25 mΩ

I_D , 1.7 A



RoHS (P)

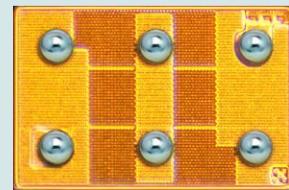
Halogen-Free

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	100	V
	Drain-to-Source Voltage (p to 10,000 5 ms pulses at 150°C)	120	
I_D	Continuous ($T_A = 25^\circ\text{C}$)	1.7	A
	Pulsed (25°C , $T_{PULSE} = 300 \mu\text{s}$)	37	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.8	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction to Board	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	92	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.
See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.



EPC2051 eGaN® FETs are supplied in passivated die form with copper pillars. Die size: 1.3 x .85 mm

Applications

- Open Rack Server Architectures
- LiDAR/Pulsed Power Applications
- Power Supplies
- Class D Audio
- LED Lighting
- Low Inductance Motor Drive

Benefits

- Ultra High Efficiency
- No Reverse Recovery
- Ultra Low Q_G
- Ultra Small Footprint

www.epc-co.com/epc/Products/eGaNFTs/EPC2051.aspx

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)					
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}$, $I_D = 300 \mu\text{A}$	100		
I_{DSS}	Drain-Source Leakage	$V_{DS} = 80 \text{ V}$, $V_{GS} = 0 \text{ V}$		4	250
I_{GSS}	Gate-to-Source Forward Leakage	$V_{GS} = 5 \text{ V}$, $T_J = 25^\circ\text{C}$		0.001	0.2
	Gate-to-Source Forward Leakage [#]	$V_{GS} = 5 \text{ V}$, $T_J = 125^\circ\text{C}$		0.04	2
	Gate-to-Source Reverse Leakage	$V_{GS} = -4 \text{ V}$		4	250
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 1.5 \text{ mA}$	0.8	1.4	2.5
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}$, $I_D = 3 \text{ A}$		20	25
V_{SD}	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}$, $V_{GS} = 0 \text{ V}$		1.9	

Defined by design. Not subject to production test.

Dynamic Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		215	258	pF
C_{RSS}			1		
C_{OSS}			86	129	
$C_{OSS(ER)}$			112		
$C_{OSS(TR)}$	$V_{DS} = 0 \text{ to } 50\text{ V}, V_{GS} = 0\text{ V}$		146		nC
R_G			0.8		
Q_G	$V_{DS} = 50\text{ V}, V_{GS} = 5\text{ V}, I_D = 3\text{ A}$		1.7	2.1	nC
Q_{GS}	$V_{DS} = 50\text{ V}, I_D = 3\text{ A}$		0.6		
Q_{GD}			0.3		
$Q_{G(TH)}$			0.4		
Q_{OSS}	$V_{GS} = 0\text{ V}, V_{DS} = 50\text{ V}$		7.3	11	
Q_{RR}			0		

Defined by design. Not subject to production test.

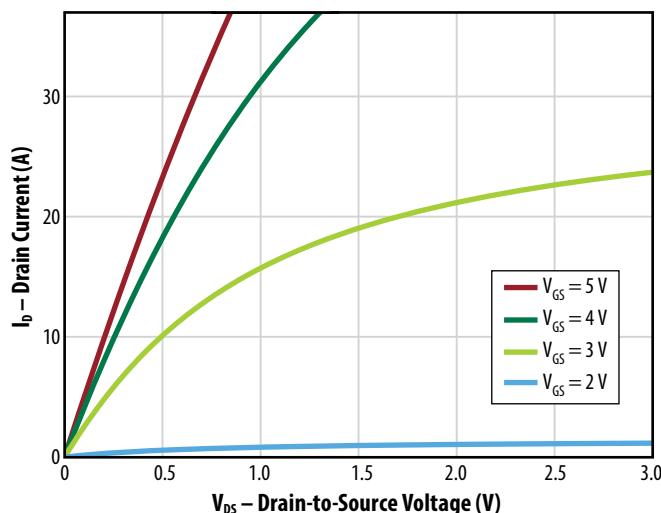
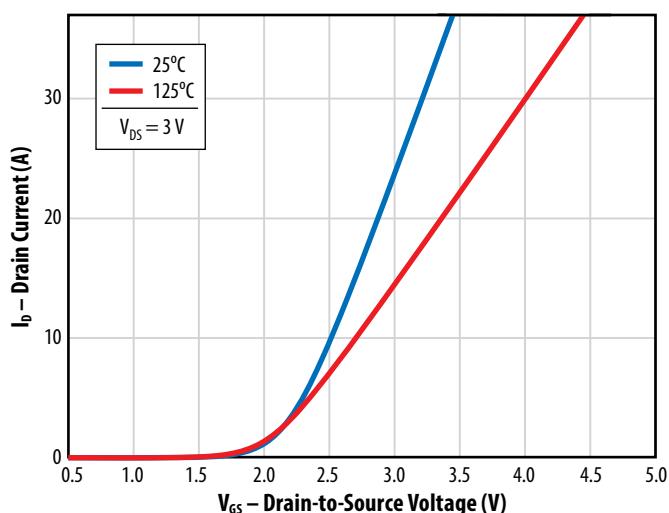
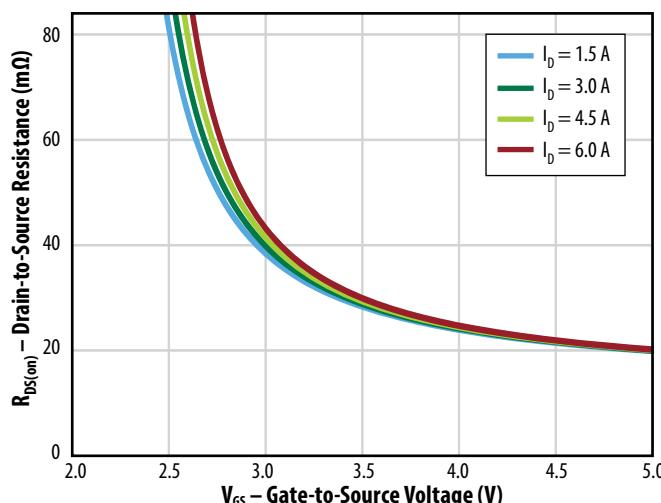
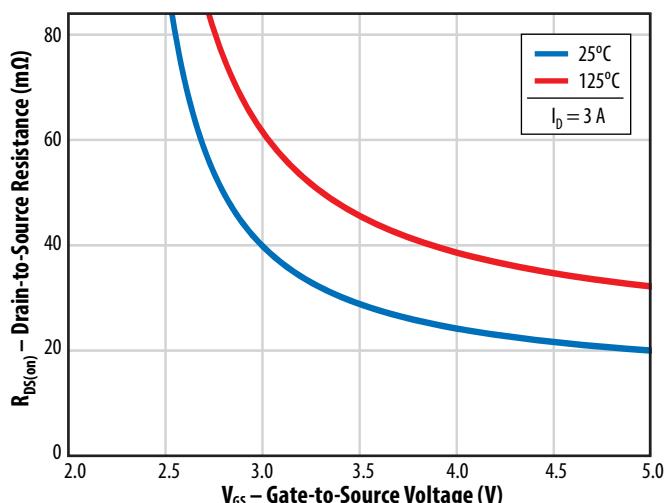
Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .Figure 1: Typical Output Characteristics at 25°C 

Figure 2: Transfer Characteristics

Figure 3: $R_{DS(on)}$ vs. V_{GS} for Various CurrentsFigure 4: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

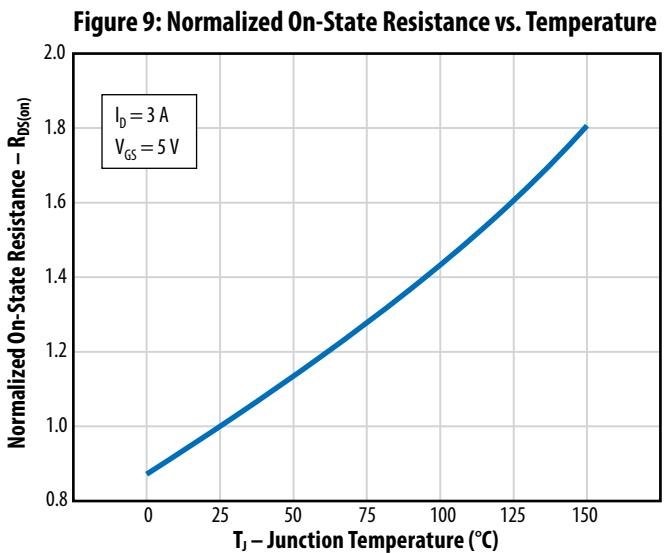
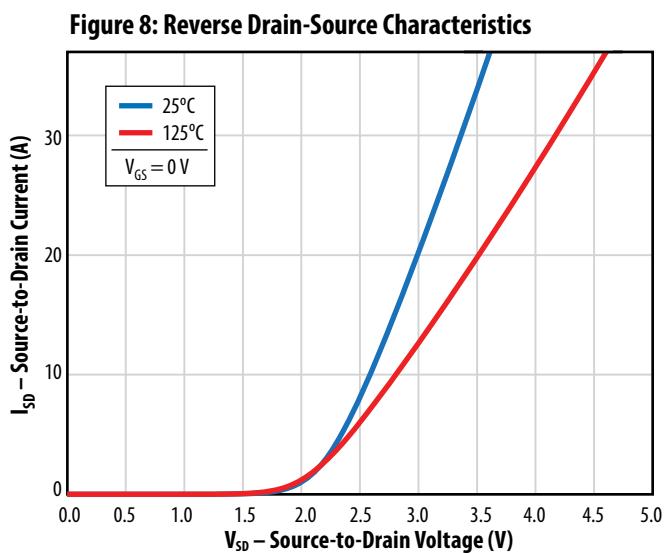
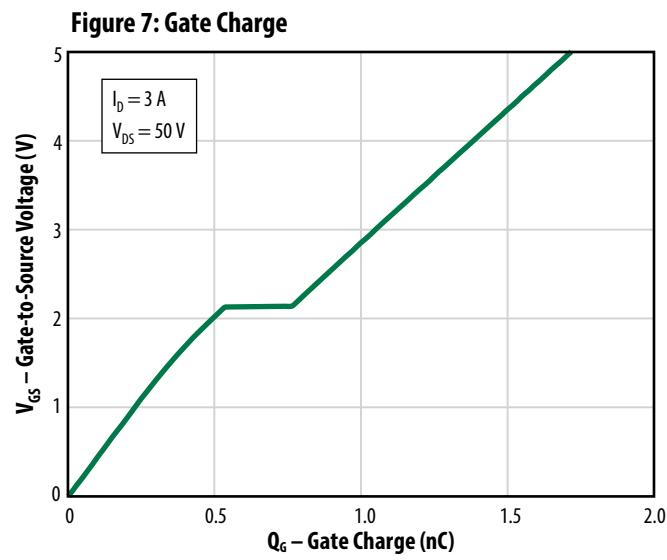
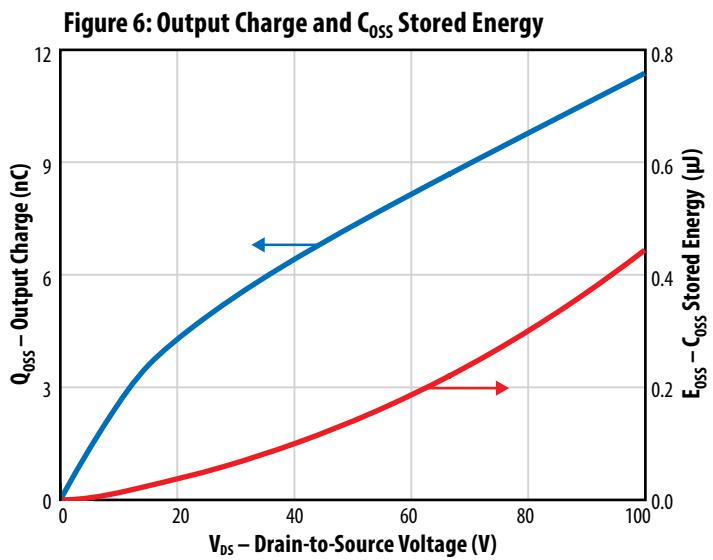
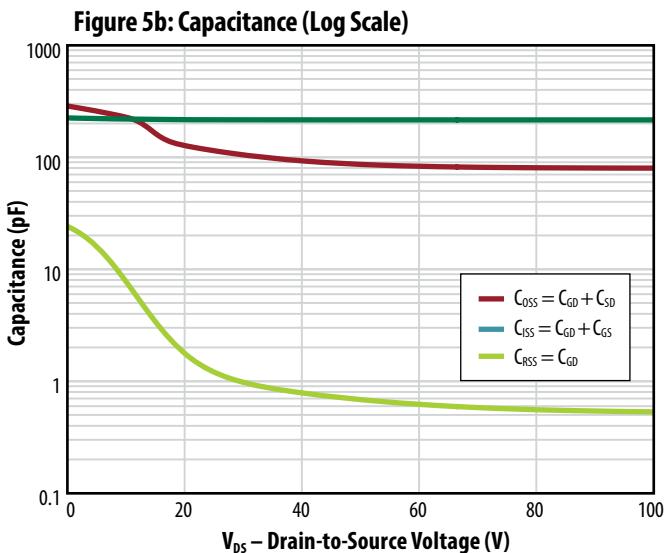
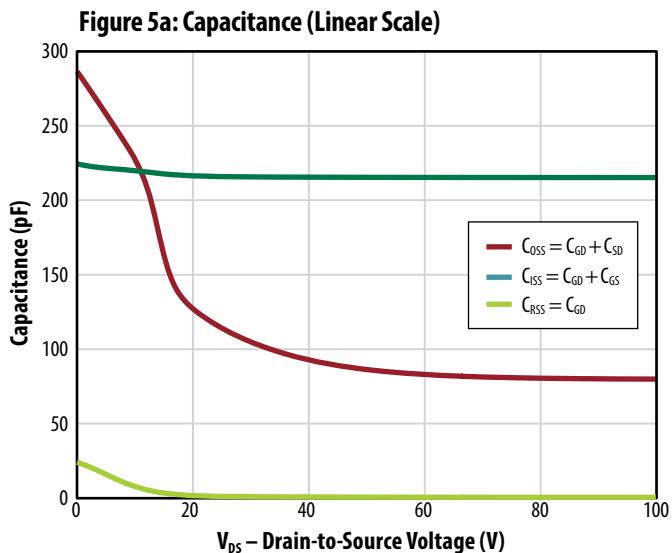


Figure 10: Normalized Threshold Voltage vs. Temperature

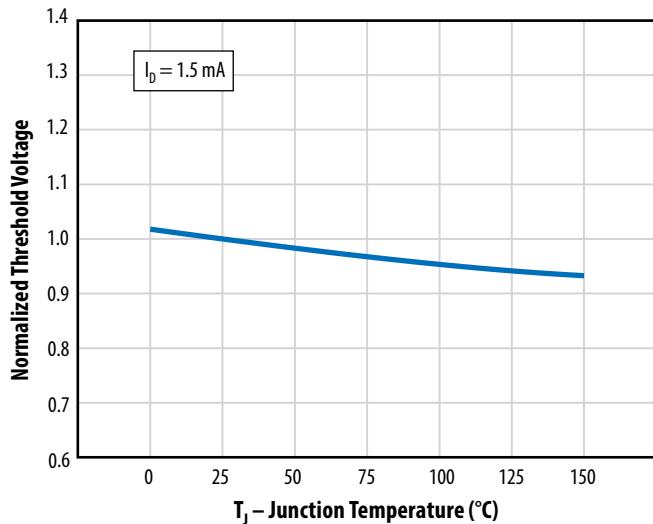


Figure 11: Transient Thermal Response Curves

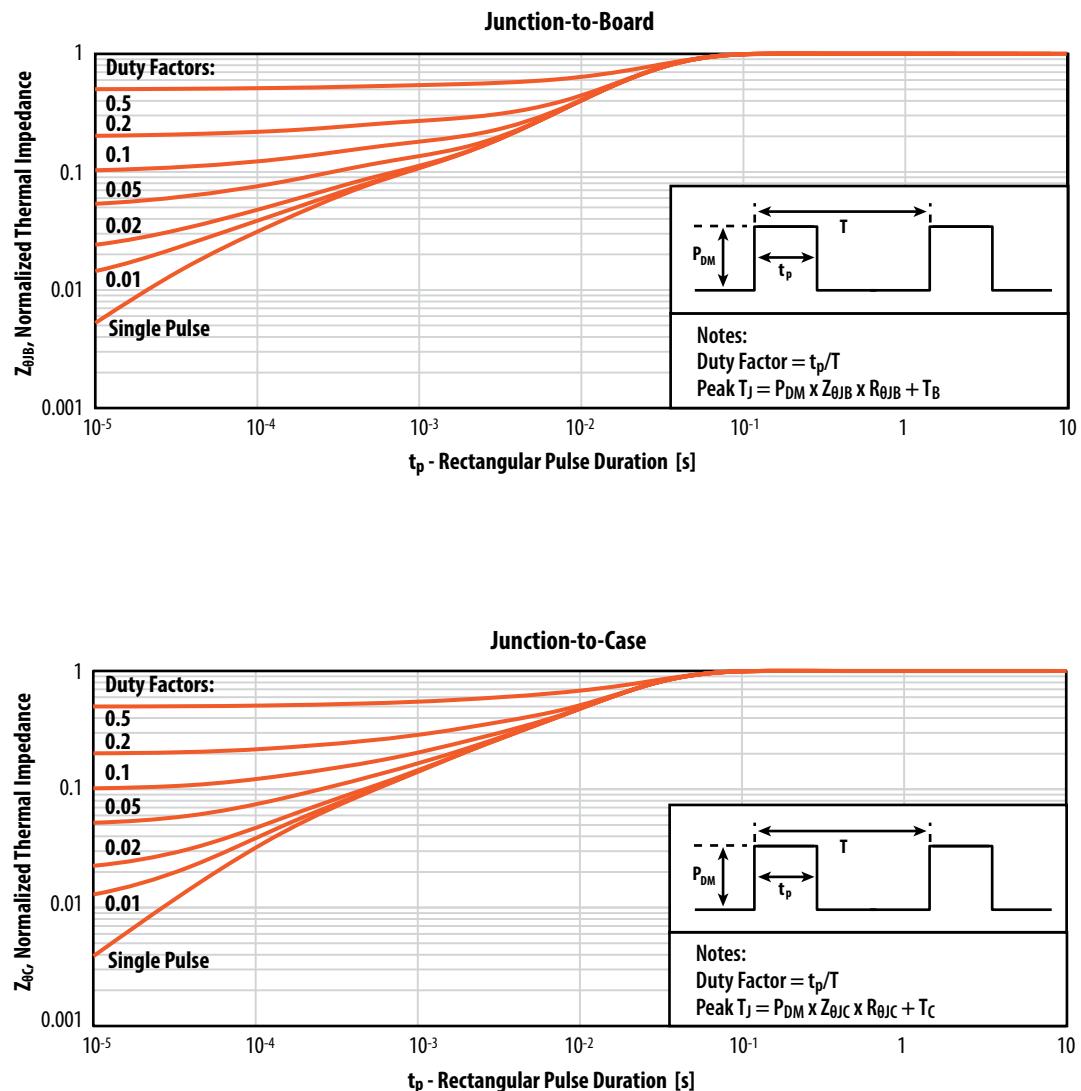
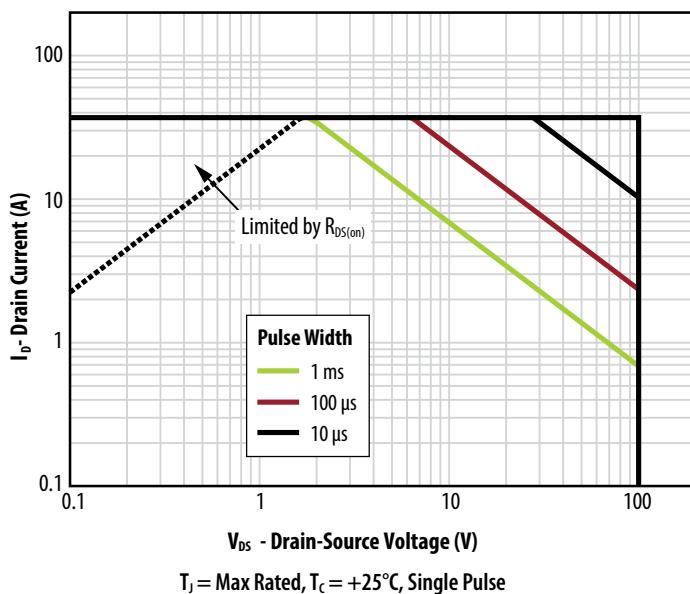
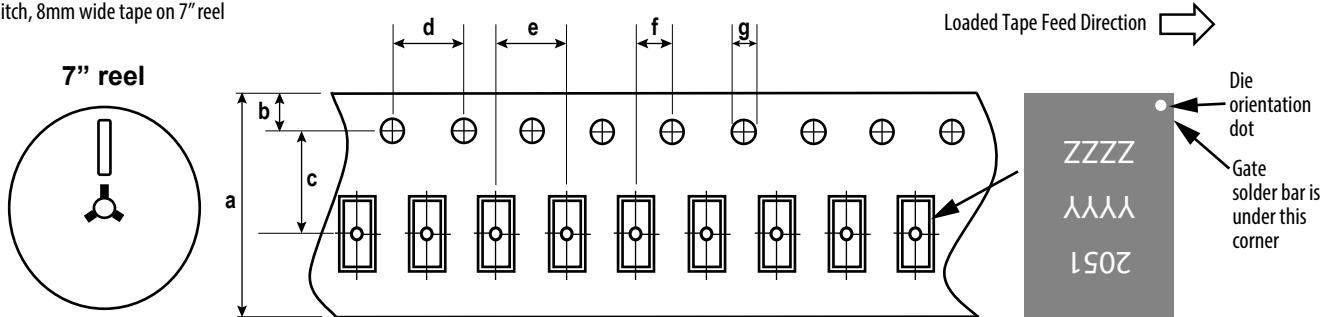


Figure 12: Safe Operating Area

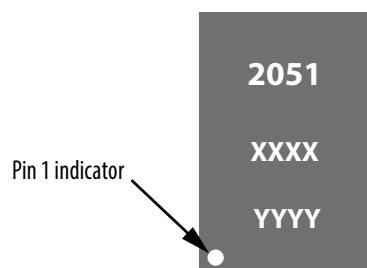
**TAPE AND REEL CONFIGURATION**

4mm pitch, 8mm wide tape on 7" reel



EPC2051 (note 1)			
Dimension (mm)	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (see note)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.5	1.5	1.6

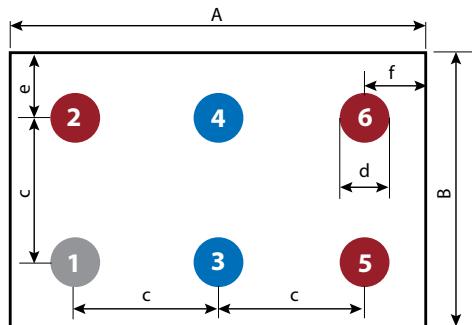
Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
 Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

DIE MARKINGS

Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking line 2	Lot_Date Code Marking Line 3
EPC2051	2051	XXXX	YYYY

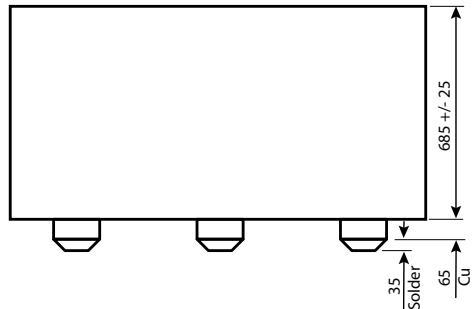
DIE OUTLINE

Solder Bar View
(looking at the Cu pillars)

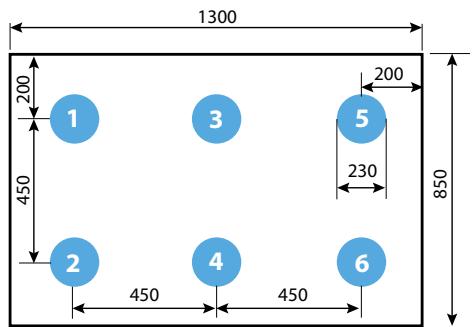


DIM	MICROMETERS		
	MIN	Nominal	MAX
A	1270	1300	1330
B	820	850	880
c		450	
d		150	
e	185	200	215
f	185	200	215

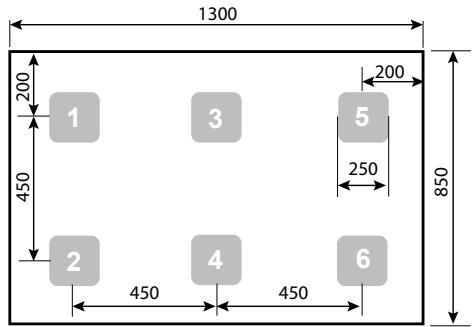
Side View



Pad 1 is Gate;
Pads 2, 5, 6 are Source;
Pads 3 & 4 are Drain;

RECOMMENDED LAND PATTERN
(units in μm)

Pad 1 is Gate;
Pads 2, 5, 6 are Source;
Pads 3 & 4 are Drain;

RECOMMENDED STENCIL DRAWING
(measurements in μm)

Preliminary Solder Flux Recommendation:
EPC uses Kester NP505-HR Type 4 Solder Paste. This solder uses ROLO type flux. It is intended that the solder completely wets the sides of the Cu Pillar. This is different from traditional Cu Pillar assembly techniques.

Additional assembly resources available at
<http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx>

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EPC Patent Listing: epc-co.com/epc/AboutEPC/Patents.aspx

Information subject to change without notice.
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